

Notice of References Cited	Application/Control No. 10/561,591		Applicant(s)/Patent Under Reexamination HELLMANN, NEIL CHRISTOPH	
	Examiner NOAH S. WIESE		Art Unit 4116	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0092848	05-2003	Sengupta et al.	525/328.5
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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